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"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

### Applications of "[Embedded - Microcontrollers](#)"

#### Details

Product Status	Active
Core Processor	e200z0h
Core Size	32-Bit Single-Core
Speed	64MHz
Connectivity	CANbus, LINbus, SPI, UART/USART
Peripherals	DMA, POR, PWM, WDT
Number of I/O	80
Program Memory Size	768KB (768K x 8)
Program Memory Type	FLASH
EEPROM Size	64K x 8
RAM Size	64K x 8
Voltage - Supply (Vcc/Vdd)	4.5V ~ 5.5V
Data Converters	A/D 26x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	144-LQFP
Supplier Device Package	144-LQFP (20x20)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/stmicroelectronics/spc56ap54l5befay">https://www.e-xfl.com/product-detail/stmicroelectronics/spc56ap54l5befay</a>

# 1 Introduction

## 1.1 Document overview

This document provides electrical specifications, pin assignments, and package diagrams for the SPC56xP54x/SPC56xP60x series of microcontroller units (MCUs). It also describes the device features and highlights important electrical and physical characteristics. For functional characteristics, refer to the device reference manual.

## 1.2 Description

This 32-bit system-on-chip (SoC) automotive microcontroller family is the latest achievement in integrated automotive application controllers. It belongs to an expanding range of automotive-focused products designed to address chassis applications specifically the airbag application.

This family is one of a series of next-generation integrated automotive microcontrollers based on the Power Architecture technology.

The advanced and cost-efficient host processor core of this automotive controller family complies with the Power Architecture embedded category. It operates up to 64 MHz and offers high performance processing optimized for low power consumption. It capitalizes on the available development infrastructure of current Power Architecture devices and is supported with software drivers, operating systems and configuration code to assist with users implementations.

## 1.3 Device comparison

[Table 2](#) provides a summary of different members of the SPC56xP54x/SPC56xP60x family and their features—relative to Full-featured version—to enable a comparison among the family members and an understanding of the range of functionality offered within this family.

**Table 2. SPC56xP54x/SPC56xP60x device comparison**

Feature	SPC560P54	SPC560P60	SPC56AP54	SPC56AP60
Code Flash memory (with ECC)	768 KB	1 MB	768 KB	1 MB
Data Flash / EE (with ECC)	64 KB			
SRAM (with ECC)	64 KB	80 KB	64 KB	80 KB
Processor core	32-bit e200z0h		32-bit Dual e200z0h	
Instruction set	VLE			
CPU performance	0-64 MHz			
FMPLL (frequency-modulated phase-locked loop) modules	1			
INTC (interrupt controller) channels	148			
PIT (periodic interrupt timer)	1 (includes four 32-bit timers)			

Table 4. SPC56xP54x/SPC56xP60x series block summary

Block	Function
Analog-to-digital converter (ADC)	Multi-channel, 10-bit analog-to-digital converter
Boot assist module (BAM)	Block of read-only memory containing VLE code which is executed according to the boot mode of the device
Clock generation module (MC_CGM)	Provides logic and control required for the generation of system and peripheral clocks
Controller area network (FlexCAN)	Supports the standard CAN communications protocol
Cross triggering unit (CTU)	Enables synchronization of ADC conversions with a timer event from the eMIOS or from the PIT
Crossbar switch (XBAR)	Supports simultaneous connections between two master ports and three slave ports. The crossbar supports a 32-bit address bus width and a 32-bit data bus width.
Cyclic redundancy checker (CRC) unit	Is dedicated to the computation of CRC off-loading the CPU. Each context has a separate CRC computation engine in order to allow the concurrent computation of the CRC of multiple data streams.
Deserial serial peripheral interface (DSPI)	Provides a synchronous serial interface for communication with external devices
Enhanced direct memory access (eDMA)	Performs complex data transfers with minimal intervention from a host processor via "n" programmable channels
Enhanced timer (eTimer)	Provides enhanced programmable up/down modulo counting
Error correction status module (ECSM)	Provides a myriad of miscellaneous control functions for the device including program-visible information about configuration and revision levels, a reset status register, wakeup control for exiting sleep modes, and optional features such as information on memory errors reported by error-correcting codes
External oscillator (XOSC)	Provides an output clock used as input reference for FMPLL_0 or as reference clock for specific modules depending on system needs
Fault collection and control unit (FCCU)	Provides functional safety to the device
Flash memory	Provides non-volatile storage for program code, constants and variables
FlexRay (FlexRay communication controller)	Provides high-speed distributed control for advanced automotive applications
Frequency-modulated phase-locked loop (FMPLL)	Generates high-speed system clocks and supports programmable frequency modulation
Interrupt controller (INTC)	Provides priority-based preemptive scheduling of interrupt requests
JTAG controller	Provides the means to test chip functionality and connectivity while remaining transparent to system logic when not in test mode
LINFlex controller	Manages a high number of LIN (Local Interconnect Network protocol) messages efficiently with a minimum of CPU load
Mode entry module (MC_ME)	Provides a mechanism for controlling the device operational mode and mode transition sequences in all functional states; also manages the power control unit, reset generation module and clock generation module, and holds the configuration, control and status registers accessible for applications

The crossbar provides the following features:

- 6 master ports:
  - 2 e200z0 core complex Instruction ports
  - 2 e200z0 core complex Load/Store Data ports
  - eDMA
  - FlexRay
- 6 slave ports:
  - 2 Flash memory (code flash and data flash)
  - 2 SRAM (48 KB + 32 KB)
  - 2 PBRIDGE
- 32-bit internal address, 32-bit internal data paths
- Fixed Priority Arbitration based on Port Master
- Temporary dynamic priority elevation of masters

### 1.5.3 Enhanced direct memory access (eDMA)

The enhanced direct memory access (eDMA) controller is a second-generation module capable of performing complex data movements via 16 programmable channels, with minimal intervention from the host processor. The hardware micro architecture includes a DMA engine which performs source and destination address calculations, and the actual data movement operations, along with an SRAM-based memory containing the transfer control descriptors (TCD) for the channels. This implementation is utilized to minimize the overall block size.

The eDMA module provides the following features:

- 16 channels support independent 8, 16 or 32-bit single value or block transfers
- Supports variable sized queues and circular queues
- Source and destination address registers are independently configured to post-increment or remain constant
- Each transfer is initiated by a peripheral, CPU, or eDMA channel request
- Each eDMA channel can optionally send an interrupt request to the CPU on completion of a single value or block transfer
- DMA transfers possible between system memories, DSPIs, ADC, eTimer and CTU
- Programmable DMA Channel Multiplexer for assignment of any DMA source to any available DMA channel with up to 30 potential request sources
- eDMA abort operation through software

### 1.5.4 On-chip flash memory with ECC

The SPC56xP54x/SPC56xP60x provides up to 1024 KB of programmable, non-volatile, flash memory. The non-volatile memory (NVM) can be used for instruction and/or data storage. The flash memory module interfaces the system bus to a dedicated flash memory array controller. It supports a 32-bit data bus width at the system bus port, and a 128-bit read data interface to flash memory. The module contains a four-entry, 4x128-bit prefetch buffers. Prefetch buffer hits allow no-wait responses. Normal flash memory array accesses are registered and are forwarded to the system bus on the following cycle, incurring 2 wait states.

### 1.5.24 Analog-to-digital converter (ADC)

The ADC module provides the following features:

Analog part:

- 1 on-chip analog-to-digital converter
- 10-bit AD resolution
- 1 sample and hold unit per ADC
- Conversion time, including sampling time, less than 1  $\mu$ s (at full precision)
- Typical sampling time is 150 ns min. (at full precision)
- Differential non-linearity error (DNL)  $\pm 1$  LSB
- Integral non-linearity error (INL)  $\pm 1.5$  LSB
- Total unadjusted error (TUE)  $< 3$  LSB
- Single-ended input signal range from 0 to 3.3 V / 5.0 V
- ADC and its reference can be supplied with a voltage independent from  $V_{DDIO}$
- ADC supply can be equal or higher than  $V_{DDIO}$
- ADC supply and the ADC reference are not independent from each other (they are internally bonded to the same pad)
- Sample times of 2 (default), 8, 64, or 128 ADC clock cycles

Digital part:

- 27 input channels (26 + 1 internally connected)
- 4 analog watchdogs to compare ADC results against predefined levels (low, high, range) before results are stored
- 2 operating modes: Normal mode and CTU control mode
- Normal mode features
  - Register-based interface with the CPU: control register, status register, 1 result register per channel
  - ADC state machine managing 3 request flows: regular command, hardware injected command, and software injected command
  - Selectable priority between software and hardware injected commands
  - DMA compatible interface
- CTU control mode features
  - Triggered mode only
  - 4 independent result queues (2  $\times$  16 entries, 2  $\times$  4 entries)
  - Result alignment circuitry (left justified; right justified)
  - 32-bit read mode allows to have channel ID on one of the 16-bit part
  - DMA compatible interfaces

### 1.5.25 Cross triggering unit (CTU)

The Cross Triggering Unit (CTU) allows automatic generation of ADC conversion requests on user selected conditions with minimized CPU load for dynamic configuration.

It implements the following features:

- Double buffered trigger generation unit with up to eight independent triggers generated from external triggers
- Trigger generation unit configurable in sequential mode or in triggered mode
- Each Trigger can be appropriately delayed to compensate the delay of external low pass filter
- Double buffered global trigger unit allowing eTimer synchronization and/or ADC command generation
- Double buffered ADC command list pointers to minimize ADC-trigger unit update
- Double buffered ADC conversion command list with up to 24 ADC commands
- Each trigger has the capability to generate consecutive commands
- ADC conversion command allows to control ADC channel from each ADC, single or synchronous sampling, independent result queue selection

### 1.5.26 Cyclic redundancy check (CRC)

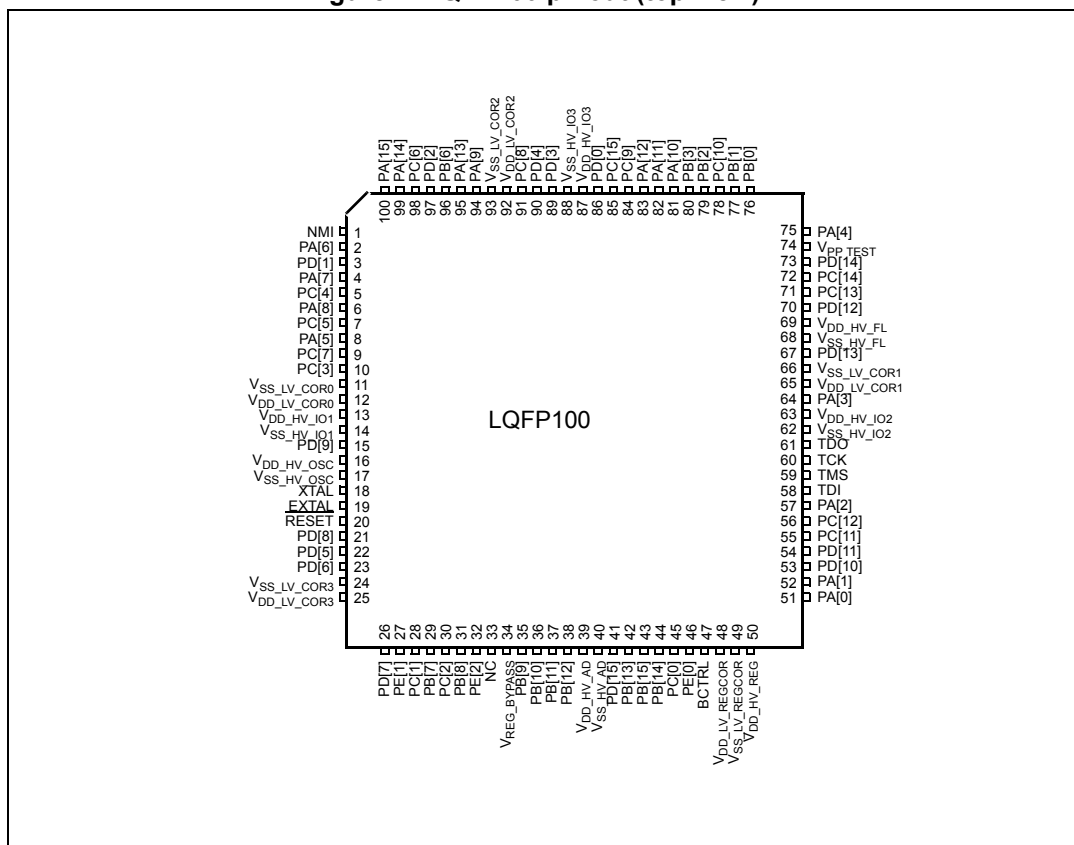
- 3 contexts for the concurrent CRC computation
- Separate CRC engine for each context
- Zero-wait states during the CRC computation (pipeline scheme)
- 3 hard-wired polynomials (CRC-8 VDA CAN, CRC-32 Ethernet and CRC-16-CCITT)
- Support for byte/half-word/word width of the input data stream
- Support for expected and actual CRC comparison

### 1.5.27 Nexus development interface (NDI)

The NDI block provides real-time development support capabilities for the SPC56xP54x/SPC56xP60x Power Architecture based MCU in compliance with the IEEE-ISTO 5001-2003 standard. This development support is supplied for MCUs without requiring external address and data pins for internal visibility. The NDI block is an integration of several individual Nexus blocks that are selected to provide the development support interface for this device. The NDI block interfaces to the host processor and internal buses to provide development support as per the IEEE-ISTO 5001-2003 Class 2+ standard. The development support provided includes access to the MCU's internal memory map and access to the processor's internal registers during run time.

The Nexus Interface provides the following features:

- Configured via the IEEE 1149.1
- All Nexus port pins operate at  $V_{DDIO}$  (no dedicated power supply)
- Nexus 2+ features supported
  - Static debug
  - Watchpoint messaging
  - Ownership trace messaging
  - Program trace messaging
  - Real time read/write of any internally memory mapped resources through JTAG pins
  - Overrun control, which selects whether to stall before Nexus overruns or keep executing and allow overwrite of information

Figure 4. LQFP100 pinout (top view)<sup>(d)</sup>

## 2.2 Pin descriptions

The following sections provide signal descriptions and related information about the functionality and configuration of the SPC56xP54x/SPC56xP60x devices.

### 2.2.1 Power supply and reference voltage pins

[Table 5](#) lists the power supply and reference voltage for the SPC56xP54x/SPC56xP60x devices.

Table 5. Supply pins

Supply		Pin		
Symbol	Description	LQFP 100	LQFP 144	LQFP 176 <sup>(1)</sup>
VREG control and power supply pins				
BCTRL	Voltage regulator external NPN Ballast base control pin	47	69	81

d. Availability of port pin alternate functions depends on product selection.

Table 7. Pin muxing<sup>(1)</sup> (continued)

Port pin	PCR No.	Alternate function <sup>(2)</sup> , (3)	Functions	Peripheral <sup>(4)</sup>	I/O direction <sup>(5)</sup>	Pad speed <sup>(6)</sup>		Pin		
						SRC = 0	SRC = 1	LQFP 100	LQFP 144	LQFP 176 <sup>(7)</sup>
B[9]	PCR[25]	ALT0 ALT1 ALT2 ALT3 —	GPIO[25] — — — AN[11]	SIUL — — — ADC_0	Input Only	—	—	35	52	60
B[10]	PCR[26]	ALT0 ALT1 ALT2 ALT3 —	GPIO[26] — — — AN[12]	SIUL — — — ADC_0	Input Only	—	—	36	53	61
B[11]	PCR[27]	ALT0 ALT1 ALT2 ALT3 —	GPIO[27] — — — AN[13]	SIUL — — — ADC_0	Input Only	—	—	37	54	62
B[12]	PCR[28]	ALT0 ALT1 ALT2 ALT3 —	GPIO[28] — — — AN[14]	SIUL — — — ADC_0	Input Only	—	—	38	55	63
B[13]	PCR[29]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[29] — — — AN[16] RXD	SIUL — — — ADC_0 LINFlex_1	Input Only	—	—	42	60	68
B[14]	PCR[30]	ALT0 ALT1 ALT2 ALT3 — — —	GPIO[30] — — — AN[17] ETC[4] EIRQ[19]	SIUL — — — ADC_0 eTimer_0 SIUL	Input Only	—	—	44	64	76
B[15]	PCR[31]	ALT0 ALT1 ALT2 ALT3 — —	GPIO[31] — — — AN[18] EIRQ[20]	SIUL — — — ADC_0 SIUL	Input Only	—	—	43	62	70



Table 7. Pin muxing<sup>(1)</sup> (continued)

Port pin	PCR No.	Alternate function <sup>(2)</sup> , (3)	Functions	Peripheral <sup>(4)</sup>	I/O direction <sup>(5)</sup>	Pad speed <sup>(6)</sup>		Pin		
						SRC = 0	SRC = 1	LQFP 100	LQFP 144	LQFP 176 <sup>(7)</sup>
D[7]	PCR[55]	ALT0 ALT1 ALT2 ALT3 —	GPIO[55] CS3_1 — CS4_0 SIN_3	SIUL DSPI_1 — DSPI_0 DSPI_3	I/O O — O I	Slow	Medium	26	37	45
D[8]	PCR[56]	ALT0 ALT1 ALT2 ALT3	GPIO[56] CS2_1 RDY CS5_0	SIUL DSPI_1 nexus_0 DSPI_0	I/O O O O	Slow	Medium	21	32	40
D[9]	PCR[57]	ALT0 ALT1 ALT2 ALT3	GPIO[57] — TXD CS6_1	SIUL — LINFlex_1 DSPI_1	I/O — O O	Slow	Medium	15	26	34
D[10]	PCR[58]	ALT0 ALT1 ALT2 ALT3	GPIO[58] — CS0_3 —	SIUL — DSPI_3 —	I/O — I/O —	Slow	Medium	53	76	92
D[11]	PCR[59]	ALT0 ALT1 ALT2 ALT3	GPIO[59] — CS1_3 SCK_3	SIUL — DSPI_3 DSPI_3	I/O — O I/O	Slow	Medium	54	78	94
D[12]	PCR[60]	ALT0 ALT1 ALT2 ALT3 —	GPIO[60] — — CS7_1 RXD	SIUL — — DSPI_1 LINFlex_1	I/O — — O I	Slow	Medium	70	99	123
D[13]	PCR[61]	ALT0 ALT1 ALT2 ALT3	GPIO[61] — CS2_3 SOUT_3	SIUL — DSPI_3 DSPI_3	I/O — O O	Slow	Medium	67	95	119
D[14]	PCR[62]	ALT0 ALT1 ALT2 ALT3 —	GPIO[62] — CS3_3 — SIN_3	SIUL — DSPI_3 — DSPI_3	I/O — O — I	Slow	Medium	73	105	129
D[15]	PCR[63]	ALT0 ALT1 ALT2 ALT3 —	GPIO[63] — — — AN[20]	SIUL — — — ADC_0	Input Only	—	—	41	58	66

Table 18. Low voltage monitor electrical characteristics

Symbol		Parameter	Conditions <sup>(1)</sup>	Value		Unit
				Min	Max	
V <sub>PORH</sub>	T	Power-on reset threshold	—	1.5	2.7	V
V <sub>PORUP</sub>	P	Supply for functional POR module	T <sub>A</sub> = 25°C	1.0	—	V
V <sub>REGLVDMOK_H</sub>	P	Regulator low voltage detector high threshold	—	—	2.95	V
V <sub>REGLVDMOK_L</sub>	P	Regulator low voltage detector low threshold	—	2.6	—	V
V <sub>FLLVDMOK_H</sub>	P	Flash memory low voltage detector high threshold	—	—	2.95	V
V <sub>FLLVDMOK_L</sub>	P	Flash memory low voltage detector low threshold	—	2.6	—	V
V <sub>IOLVDMOK_H</sub>	P	I/O low voltage detector high threshold	—	—	2.95	V
V <sub>IOLVDMOK_L</sub>	P	I/O low voltage detector low threshold	—	2.6	—	V
V <sub>IOLVDM5OK_H</sub>	P	I/O 5V low voltage detector high threshold	—	—	4.4	V
V <sub>IOLVDM5OK_L</sub>	P	I/O 5V low voltage detector low threshold	—	3.8	—	V
V <sub>MLVDDOK_H</sub>	P	Digital supply low voltage detector high	—	—	1.15	V
V <sub>MLVDDOK_L</sub>	P	Digital supply low voltage detector low	—	1.08	—	V

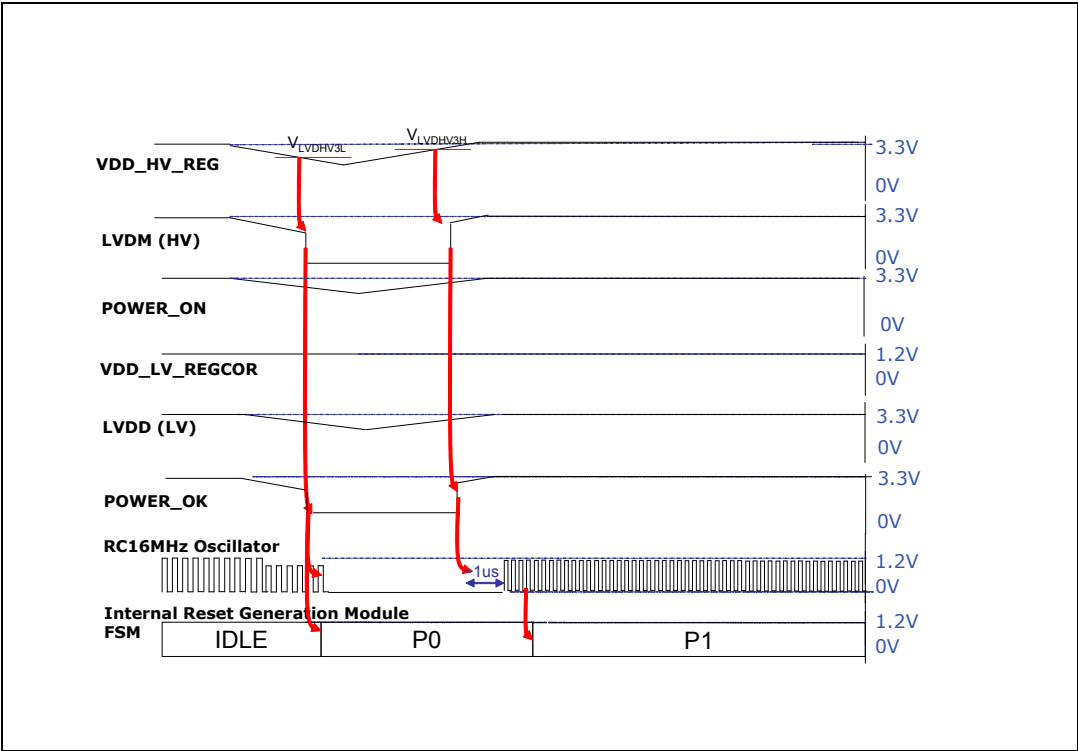
1. V<sub>DD</sub> = 3.3V ± 10% / 5.0V ± 10%, T<sub>A</sub> = -40 °C to T<sub>A</sub> MAX, unless otherwise specified.

### 3.9 Power Up/Down sequencing

To prevent an overstress event or a malfunction within and outside the device, the SPC56xP54x/SPC56xP60x implements the following sequence to ensure each module is started only when all conditions for switching it ON are available:

1. A POWER\_ON module working on voltage regulator supply controls the correct start-up of the regulator. This is a key module ensuring safe configuration for all voltage regulator functionality when supply is below 1.5V. Associated POWER\_ON (or POR) signal is active low.
  - Several low voltage detectors, working on voltage regulator supply monitor the voltage of the critical modules (voltage regulator, I/Os, flash memory and low voltage domain). LVDs are gated low when POWER\_ON is active.
  - A POWER\_OK signal is generated when all critical supplies monitored by the LVD are available. This signal is active high and released to all modules including I/Os, flash memory and RC16 oscillator needed during power-up phase and reset phase. When POWER\_OK is low the associated modules are set into a safe state.

Figure 12. Brown-out typical sequence



### 3.10 NVUSRO register

Portions of the device configuration, such as high voltage supply, and watchdog enable/disable after reset are controlled via bit values in the non-volatile user options register (NVUSRO) register.

For a detailed description of the NVUSRO register, please refer to the device reference manual.

#### 3.10.1 NVUSRO[PAD3V5V] field description

Table 19 shows how NVUSRO[PAD3V5V] controls the device configuration.

Table 19. PAD3V5V field description<sup>(1)</sup>

Value <sup>(2)</sup>	Description
0	High voltage supply is 5.0 V
1	High voltage supply is 3.3 V

1. See the device reference manual for more information on the NVUSRO register.
2. '1' is delivery value. It is part of shadow Flash, thus programmable by customer.

The DC electrical characteristics are dependent on the PAD3V5V bit value.

The filter at the input pins must be designed taking into account the dynamic characteristics of the input signal (bandwidth) and the equivalent input impedance of the ADC itself.

In fact a current sink contributor is represented by the charge sharing effects with the sampling capacitance: being  $C_S$  and  $C_{P2}$  substantially two switched capacitances, with a frequency equal to the ADC conversion rate, it can be seen as a resistive path to ground. For instance, assuming a conversion rate of 1 MHz, with  $C_S + C_{P2}$  equal to 3 pF, a resistance of 330 kΩ is obtained ( $R_{EQ} = 1 / (f_c \times (C_S + C_{P2}))$ ), where  $f_c$  represents the conversion rate at the considered channel). To minimize the error induced by the voltage partitioning between this resistance (sampled voltage on  $C_S + C_{P2}$ ) and the sum of  $R_S + R_F$ , the external circuit must be designed to respect the [Equation 4](#):

#### Equation 4

$$V_A \times \frac{R_S + R_F}{R_{EQ}} < \frac{1}{2} \text{ LSB}$$

[Equation 4](#) generates a constraint for external network design, in particular on resistive path. Internal switch resistances ( $R_{SW}$  and  $R_{AD}$ ) can be neglected with respect to external resistances.

**Figure 16. Input equivalent circuit (precise channels)**

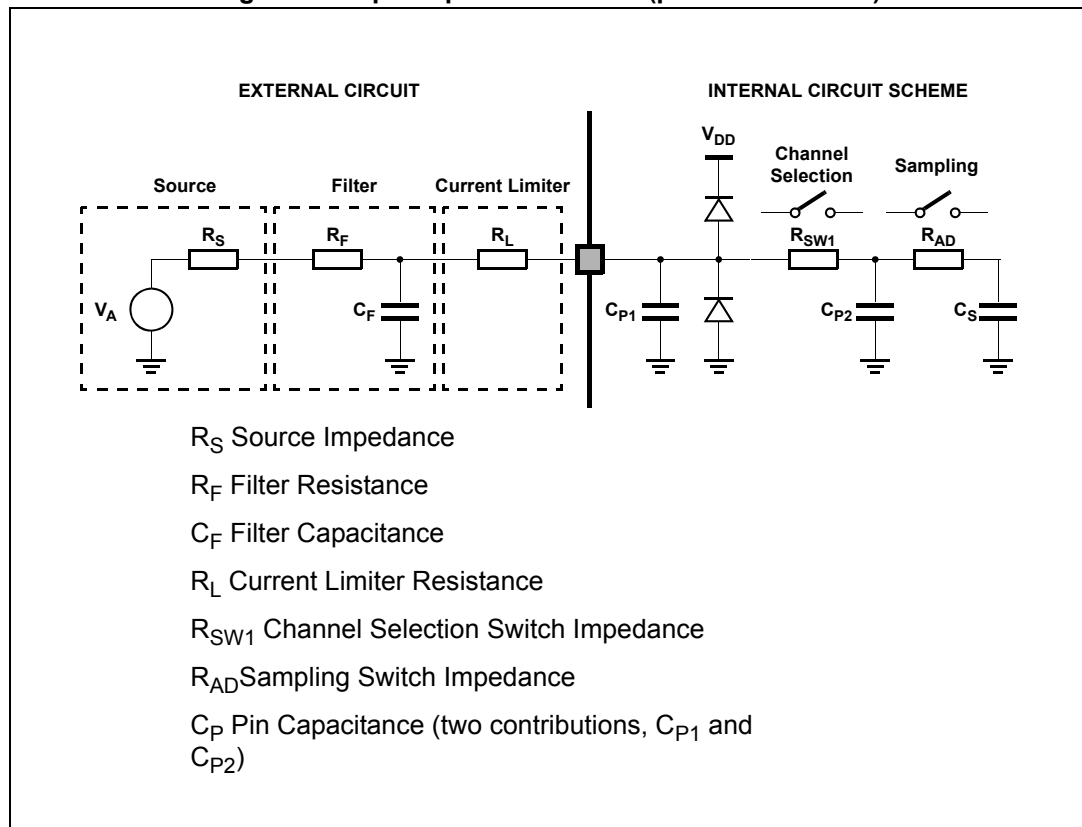


Table 37. RESET electrical characteristics

Symbol		C	Parameter	Conditions <sup>(1)</sup>	Value			Unit
					Min	Typ	Max	
V <sub>IH</sub>	SR	P	Input High Level CMOS (Schmitt Trigger)	—	0.65V <sub>DD</sub>	—	V <sub>DD</sub> +0.4	V
V <sub>IL</sub>	SR	P	Input low Level CMOS (Schmitt Trigger)	—	−0.4	—	0.35V <sub>DD</sub>	V
V <sub>HYS</sub>	CC	C	Input hysteresis CMOS (Schmitt Trigger)	—	0.1V <sub>DD</sub>	—	—	V
V <sub>OL</sub>	CC	P	Output low level	Push Pull, I <sub>OL</sub> = 2mA, V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0 (recommended)	—	—	0.1V <sub>DD</sub>	V
				Push Pull, I <sub>OL</sub> = 1mA, V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 1 <sup>(2)</sup>	—	—	0.1V <sub>DD</sub>	
				Push Pull, I <sub>OL</sub> = 1mA, V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1 (recommended)	—	—	0.5	
T <sub>tr</sub>	CC	D	Output transition time output pin <sup>(3)</sup> MEDIUM configuration	C <sub>L</sub> = 25pF, V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0	—	—	10	ns
				C <sub>L</sub> = 50pF, V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0	—	—	20	
				C <sub>L</sub> = 100pF, V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0	—	—	40	
				C <sub>L</sub> = 25pF, V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1	—	—	12	
				C <sub>L</sub> = 50pF, V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1	—	—	25	
				C <sub>L</sub> = 100pF, V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1	—	—	40	
W <sub>FRST</sub>	SR	P	RESET <sub>‾</sub> input filtered pulse	—	—	—	40	ns
W <sub>NFRST</sub>	SR	P	RESET <sub>‾</sub> input not filtered pulse	—	500	—	—	ns
T <sub>POR</sub>	CC	D	maximum delay before internal reset is released after all VDD_HV reach nominal supply	Monotonic VDD_HV supply ramp	—	—	1	ms
I <sub>WPUL</sub>	CC	P	Weak pull-up current absolute value	V <sub>DD</sub> = 3.3 V ± 10%, PAD3V5V = 1	10	—	150	μA
				V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 0	10	—	150	
				V <sub>DD</sub> = 5.0 V ± 10%, PAD3V5V = 1 <sup>(4)</sup>	10	—	250	

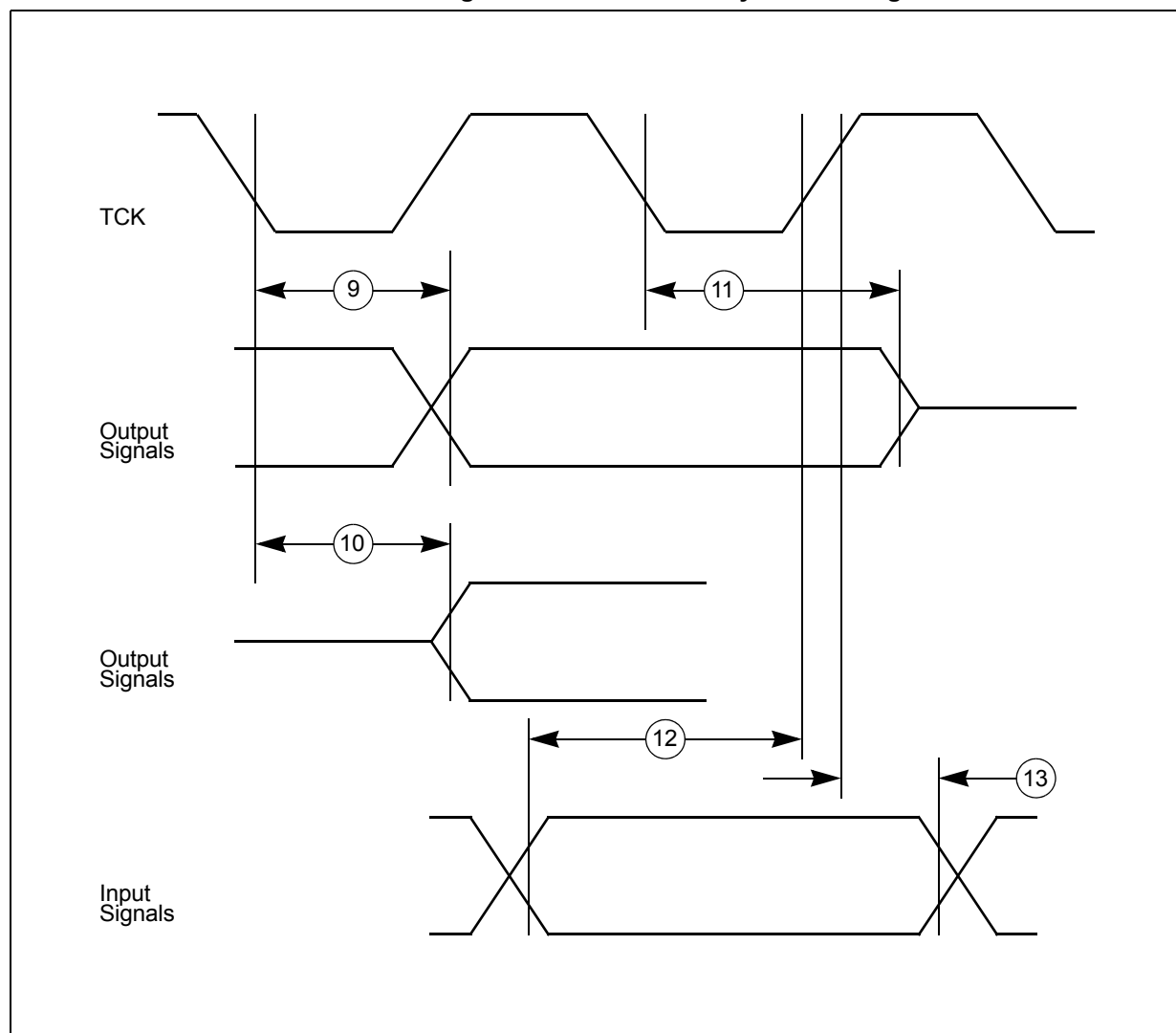
1. V<sub>DD</sub> = 3.3 V ± 10% / 5.0 V ± 10%, T<sub>A</sub> = −40 °C to T<sub>A</sub> MAX, unless otherwise specified.

2. This is a transient configuration during power-up, up to the end of reset PHASE2 (refer to RGM module section of device reference manual).

3. C<sub>L</sub> includes device and package capacitance (C<sub>PKG</sub> < 5 pF).

4. The configuration PAD3V5 = 1 when V<sub>DD</sub> = 5 V is only transient configuration during power-up. All pads but RESET and Nexus output (MDOx, EVTO, MCKO) are configured in input or in high impedance state.

Figure 24. JTAG boundary scan timing



### 3.18.3 Nexus timing

Table 39. Nexus debug port timing<sup>(1)</sup>

No.	Symbol	C	Parameter	Value			Unit
				Min	Typ	Max	
1	$t_{MCYC}$	CC	D MCKO cycle time	32	—	—	ns
2	$t_{MDOV}$	CC	D MCKO edge to MDO data valid	— $0.1 \times t_{MCYC}$	—	$0.25 \times t_{MCYC}$	ns
3	$t_{MSEOV}$	CC	D MCKO edge to $\overline{MSEO}$ data valid	— $0.1 \times t_{MCYC}$	—	$0.25 \times t_{MCYC}$	ns
4	$t_{EVT OV}$	CC	D MCKO edge to $\overline{EVTO}$ data valid	— $0.1 \times t_{MCYC}$	—	$0.25 \times t_{MCYC}$	ns
5	$t_{TCYC}$	CC	D TCK cycle time	$64^{(2)}$	—	—	ns

Table 39. Nexus debug port timing<sup>(1)</sup> (continued)

No.	Symbol		C	Parameter	Value			Unit
					Min	Typ	Max	
6	$t_{\text{NTDIS}}$	CC	D	TDI data setup time	6	—	—	ns
	$t_{\text{NTMSS}}$	CC	D	TMS data setup time	6	—	—	ns
7	$t_{\text{NTDIH}}$	CC	D	TDI data hold time	10	—	—	ns
	$t_{\text{NTMSH}}$	CC	D	TMS data hold time	10	—	—	ns
8	$t_{\text{TDOV}}$	CC	D	TCK low to TDO data valid	—	—	35	ns
9	$t_{\text{TDOI}}$	CC	D	TCK low to TDO data invalid	6	—	—	ns

1. All values need to be confirmed during device validation.
2. Lower frequency is required to be fully compliant to standard.

Figure 25. Nexus output timing

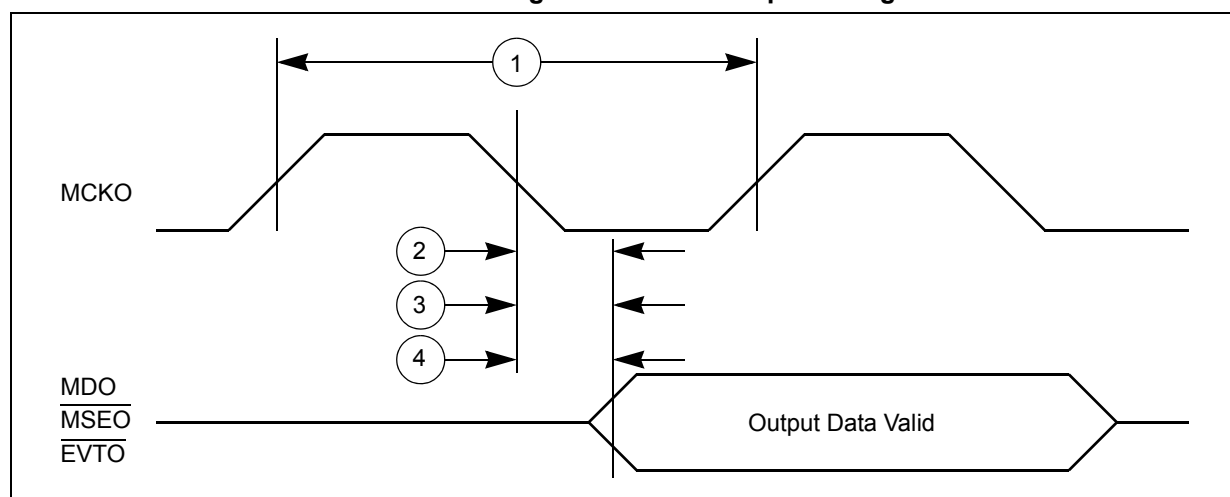


Figure 26. Nexus event trigger and test clock timings

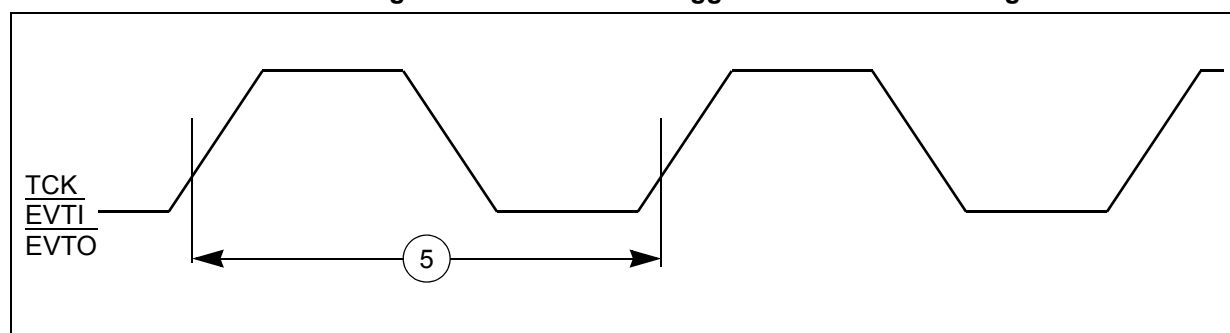
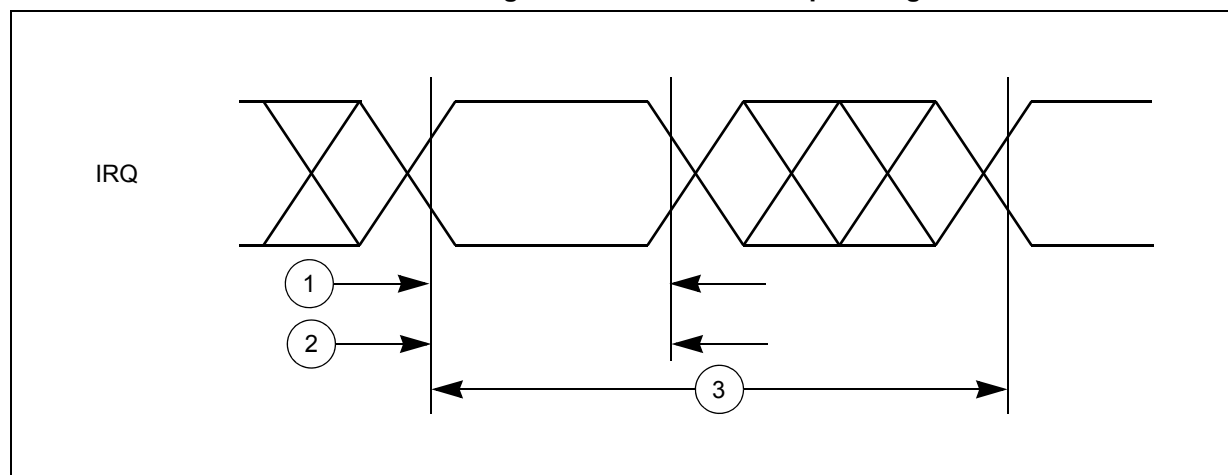


Figure 28. External interrupt timing



### 3.18.5 DSPI timing

Table 41. DSPI timing<sup>(1)</sup>

No.	Symbol	C	Parameter	Conditions	Min	Max	Unit	
1	$t_{SCK}$	CC	D	DSPI cycle time	Master (MTFE = 0)	60	—	ns
					Slave (MTFE = 0)	60	—	
2	$t_{CSC}$	CC	D	PCS to SCK delay	—	16	—	ns
3	$t_{ASC}$	CC	D	After SCK delay	—	26	—	ns
4	$t_{SDC}$	CC	D	SCK duty cycle	—	$0.4 \times t_{SCK}$	$0.6 \times t_{SCK}$	ns
5	$t_A$	CC	D	Slave access time	$\overline{SS}$ active to SOUT valid	—	30	ns
6	$t_{DIS}$	CC	D	Slave SOUT disable time	$\overline{SS}$ inactive to SOUT High-Z or invalid	—	16	ns
7	$t_{PCSC}$	CC	D	PCSx to $\overline{PCSS}$ time	—	13	—	ns
8	$t_{PASC}$	CC	D	$\overline{PCSS}$ to PCSx time	—	13	—	ns
9	$t_{SUI}$	CC	D	Data setup time for inputs	Master (MTFE = 0)	35	—	ns
					Slave	4	—	
					Master (MTFE = 1, CPHA = 0)	35	—	
					Master (MTFE = 1, CPHA = 1)	35	—	
10	$t_{HI}$	CC	D	Data hold time for inputs	Master (MTFE = 0)	–5	—	ns
					Slave	4	—	
					Master (MTFE = 1, CPHA = 0)	11	—	
					Master (MTFE = 1, CPHA = 1)	–5	—	
11	$t_{SUO}$	CC	D	Data valid (after SCK edge)	Master (MTFE = 0)	—	12	ns
					Slave	—	36	
					Master (MTFE = 1, CPHA = 0)	—	12	
					Master (MTFE = 1, CPHA = 1)	—	12	



Figure 32. DSPI classic SPI timing — slave, CPHA = 1

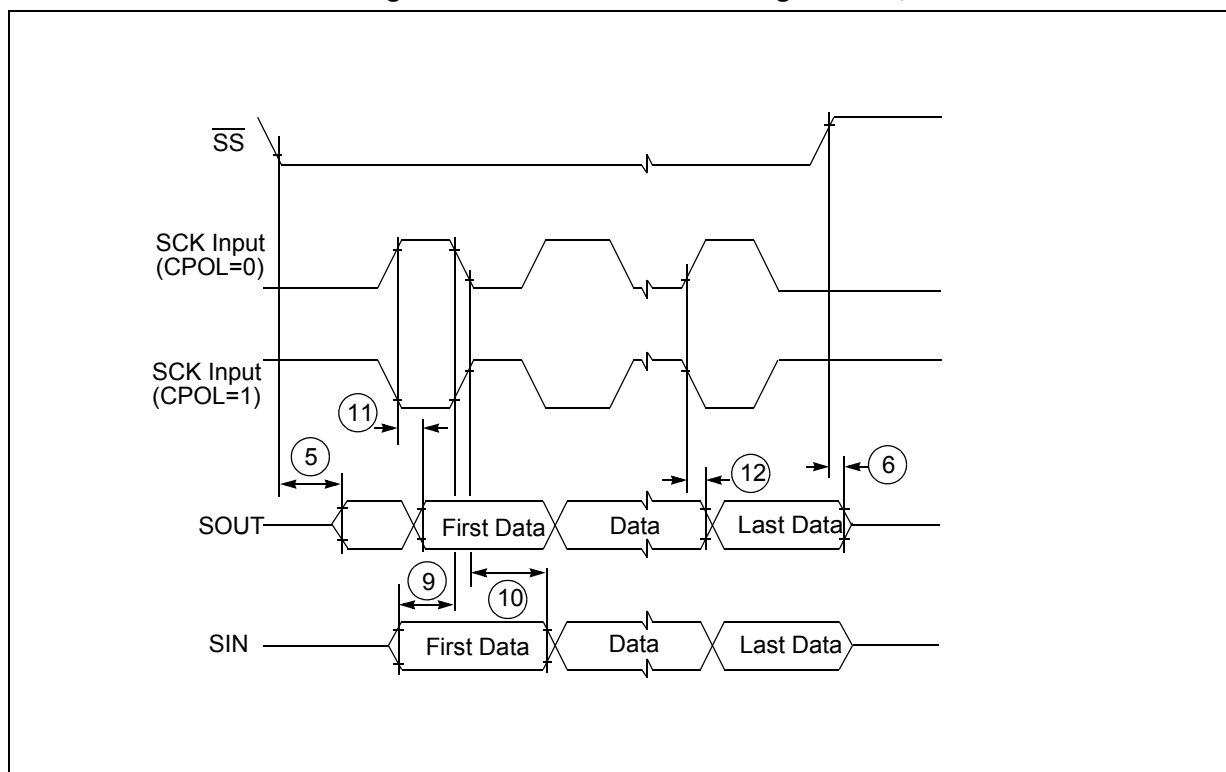
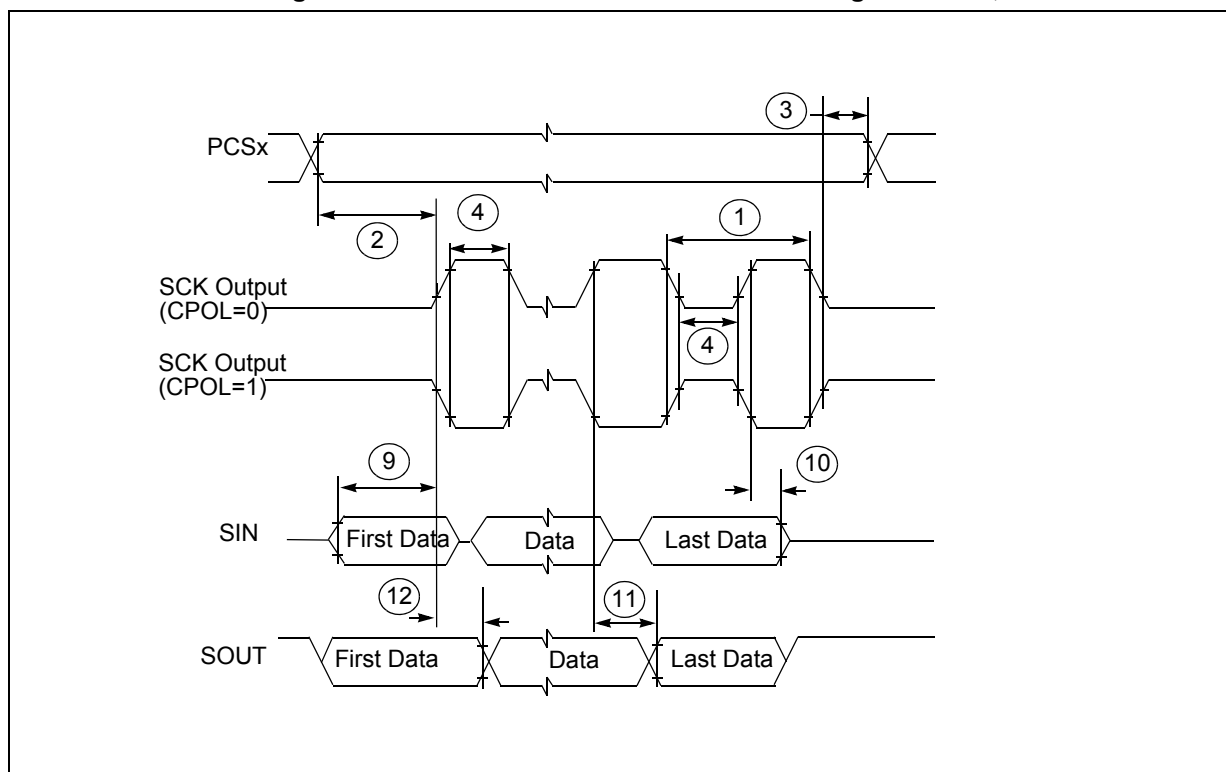


Figure 33. DSPI modified transfer format timing — master, CPHA = 0



## 4 Package characteristics

### 4.1 ECOPACK®

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK® is an ST trademark.

### 4.2 Package mechanical data

#### 4.2.1 LQFP144 mechanical outline drawing

Figure 38. LQFP144 package mechanical drawing

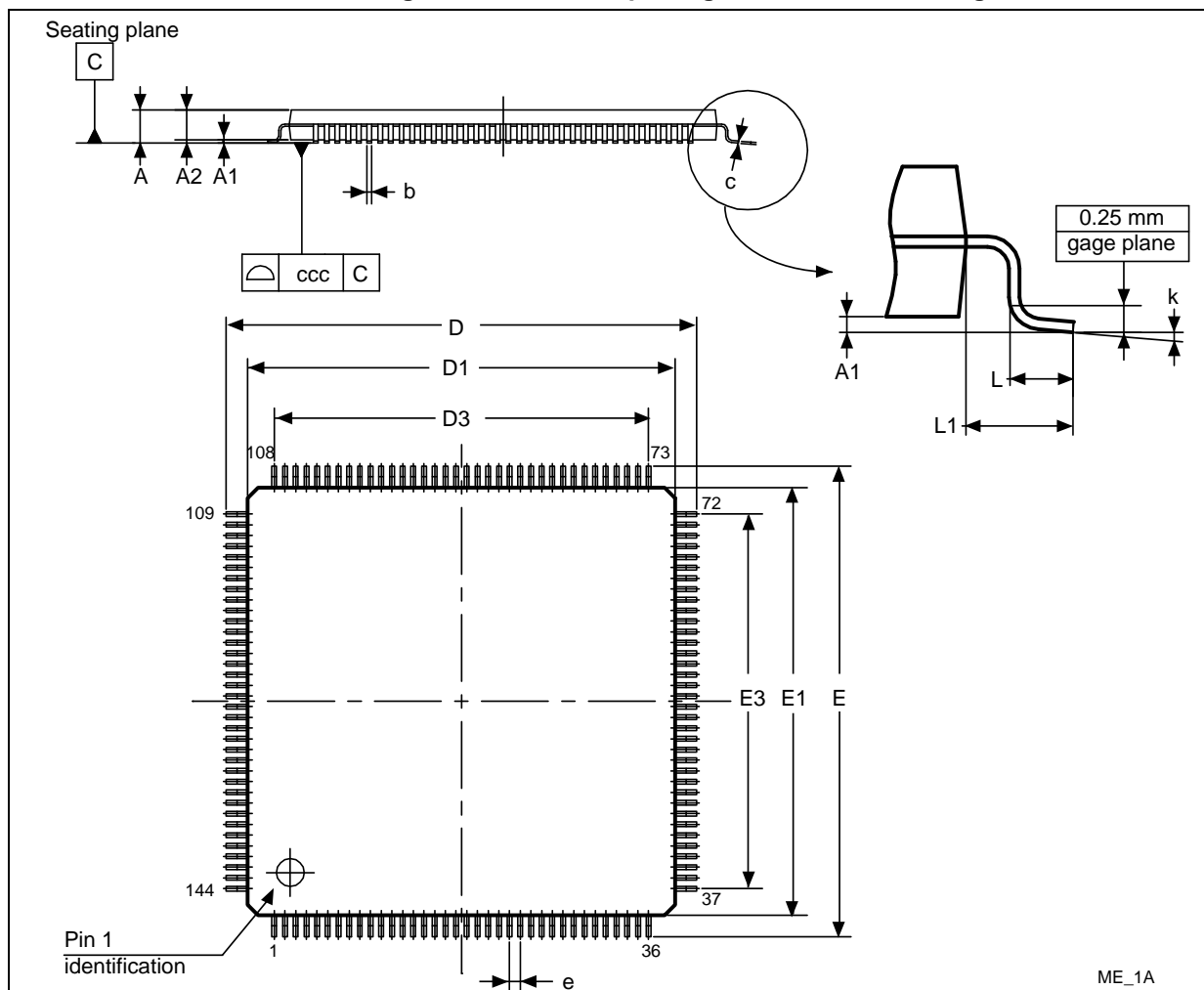




Table 43. LQFP100 mechanical data (continued)

Symbol	mm			inches <sup>(1)</sup>		
	Min	Typ	Max	Min	Typ	Max
b	0.170	0.220	0.270	0.0067	0.0087	0.0106
c	0.090	—	0.200	0.0035	—	0.0079
D	15.800	16.000	16.200	0.6220	0.6299	0.6378
D1	13.800	14.000	14.200	0.5433	0.5512	0.5591
D3	—	12.000	—	—	0.4724	—
E	15.800	16.000	16.200	0.6220	0.6299	0.6378
E1	13.800	14.000	14.200	0.5433	0.5512	0.5591
E3	—	12.000	—	—	0.4724	—
e	—	0.500	—	—	0.0197	—
L	0.450	0.600	0.750	0.0177	0.0236	0.0295
L1	—	1.000	—	—	0.0394	—
k	0.0 °	3.5 °	7.0 °	0.0 °	3.5 °	7.0 °
ccc <sup>(2)</sup>	0.080			0.0031		

1. Values in inches are converted from mm and rounded to 4 decimal digits.

2. Tolerance.

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